

Application/Control No.		Applicant(s)/Patent under Reexamination		
09/139,023		TAKI ET AL.		
Examiner		Art Unit		
Joseph R. Pokrz	zywa	2622		

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Class	Subclass	Date	Examiner
358	1.9 1.13 450 453 462	5/05	J.P.
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714	748		
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
358	1.15	5/05	J.P.			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
SEARCH EAST (ATTACHED)	5/05	J.P.		
UPDATED SEARCH	5/05	J.P.		
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